## Notice of References Cited Application/Control No. 10/817,527 Examiner Derek S. Chapel Applicant(s)/Patent Under Reexamination KRAHMER ET AL. Page 1 of 1

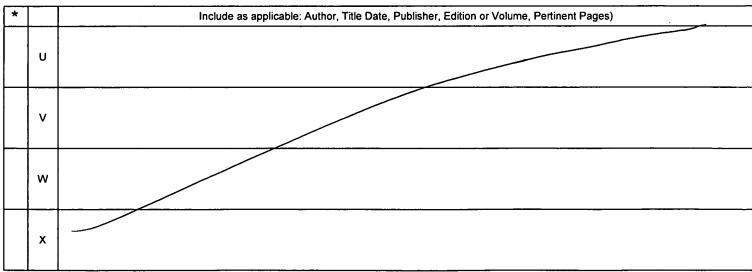
## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2004/0105170	06-2004	Krahmer et al.	359/726
	В	US-			
	С	US-			
	D	US-			
	E	US-			
	F	US-			_
	G	US-			
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	Κ	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

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## **NON-PATENT DOCUMENTS**



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